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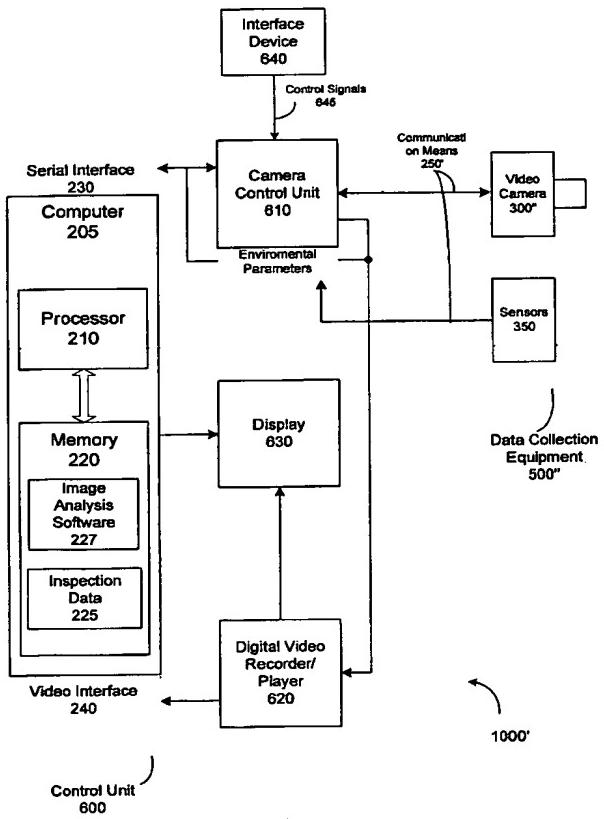
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(54) Title: AUTOMATED INSPECTION AND PROCESSING SYSTEM



(57) Abstract: An automated inspection system is provided wherein an inspection of a surface and the processing of inspection data acquired from the surface can be performed with limited or no operator involvement and wherein a high level of consistency can be maintained between each inspection and between each processing of inspection data across multiple inspections of the surface.

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